

Search Notes

Application/Control No.

10/809,359

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

2182

SEARCHED

Class	Subclass	Date	Examiner
710	62	9/26/2006	ASC
↓	72	↓	↓
↓	74	↓	↓
711	100	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
(EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT; Inventor Search	9/26/2006	ASC